Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/717,678	HAYO ET AL.
Examiner	Art Unit
Demetrius R. Pretlow	2863

	SEARCHED						
Class	Subclass	Date	Examiner				
702	140	6/8/05	20				
	197	618/05	DP.				
708	200	6/8/05	DP				

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted David Malzahn. Gene me Seurch 708/300	6/7/05	ve
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